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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/044,355	KAGAMI ET AL.	
Examiner	Art Unit	
Duyen M. Doan	2152	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
see attached search note for updated East text search (us pgpub, uspat, epo, jpo, derwent, ibm)	9/16/2006	DD
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